

## 2N4125

## PNP EPITAXIAL SILICON TRANSISTOR

T-29-21

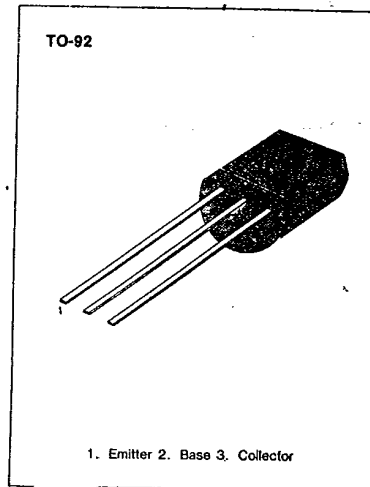
## AMPLIFIER TRANSISTOR

- Collector-Emitter Voltage:  $V_{CE0} = 30\text{ V}$
- Collector Dissipation:  $P_C(\text{max}) = 625\text{ mW}$

ABSOLUTE MAXIMUM RATINGS ( $T_a = 25^\circ\text{C}$ )

Characteristic	Symbol	Rating	Unit
Collector-Emitter Voltage	$V_{CE0}$	30	V
Collector-Base Voltage	$V_{CBO}$	30	V
Emitter-Base Voltage	$V_{EBO}$	4	V
Collector Current	$I_C$	200	mA
Collector Dissipation	$P_C$	625	mW
Junction Temperature	$T_j$	150	$^\circ\text{C}$
Storage Temperature	$T_{stg}$	-55 - 150	$^\circ\text{C}$

\* Refer to 2N3906 for graphs



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ELECTRICAL CHARACTERISTICS ( $T_a = 25^\circ\text{C}$ )

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
*Collector-Emitter Breakdown Voltage <sup>1</sup>	$BV_{CE0}$	$I_C = 1\text{ mA}, I_B = 0$	30			V
Collector-Base Breakdown Voltage	$BV_{CBO}$	$I_C = 10\ \mu\text{A}, I_E = 0$	30			V
Emitter-Base Breakdown Voltage	$BV_{EBO}$	$I_E = 10\ \mu\text{A}, I_C = 0$	4			V
Collector Cut-off Current	$I_{CBO}$	$V_{CB} = 20\text{ V}, I_E = 0$			50	nA
Emitter Cut-off Current	$I_{EBO}$	$V_{BE} = 3\text{ V}, I_C = 0$			50	nA
*DC Current Gain	$h_{FE}$	$I_C = 2\text{ mA}, V_{CE} = 1\text{ V}$	50		150	
		$I_C = 50\text{ mA}, V_{CE} = 1\text{ V}$	25			
*Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = 50\text{ mA}, I_B = 5\text{ mA}$			0.4	V
*Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C = 50\text{ mA}, I_B = 5\text{ mA}$			0.95	V
Current Gain Bandwidth Product	$f_T$	$I_C = 10\text{ mA}, V_{CE} = 20\text{ V}$ $f = 100\text{ MHz}$	200			MHz
Collector Base Capacitance	$C_{Cb}$	$V_{CB} = 5\text{ V}, I_E = 0, f = 1\text{ MHz}$			4.5	pF
Noise Figure	NF	$I_C = 100\ \mu\text{A}, V_{CE} = 5\text{ V}$ $R_G = 1\text{ K}\Omega$ Noise Bandwidth = 10Hz to 15.7KHz			5	dB

\*Pulse Test: Pulse Width  $\leq 300\ \mu\text{s}$ , Duty Cycle  $\leq 2\%$ 